Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/829,383	SATOH, HIROSHI	
Examiner	Art Unit	
Seved Azarian	2624	

SEARCHED				
Class	Subclass	Date	Examiner	
382	103,104 106-107 168,181	6/23/2007	S.A	
382	190-194	6/23/2007	S.A	
382	232,255	6/23/2007	S.A	
382	260,274	6/23/2007	S.A	
382	275,286	6/23/2007	S.A	
382	291,295	6/23/2007	S.A	
382	312	6/23/2007	S.A	
250	221	6/24/2007	S.A	
250	208.1	6/24/2007	S.A	
280	735	6/24/2007	S.A	
700	83	6/24/2007	S.A	
396	55	6/24/2007	S.A	
348	208.99	1/12/2008	S.A	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
INVENTO SERACH	6/23/2007	S.A	
EAST SEARCH	6/23/2007	S.A	
IEEE/NPL SEARCH	6/24/2007	S.A	
UPDATED SEARCH	1/12/2008	S.A	